

Description

The DGTD65T50S1PT is produced using advanced Field Stop Trench IGBT Technology, which provides excellent quality and high-switching performance.

Features

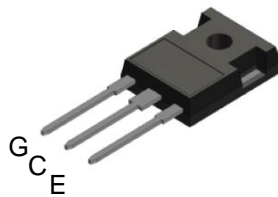
- High-Speed Switching & Low Power Loss
- $V_{CE(sat)} = 1.85V @ I_C = 50A$
- High Input Impedance
- $t_{rr} = 80ns$ (typ) @ $di_f/dt = 1000A/\mu s$
- $E_{off} = 0.55mJ @ T_C = 25^\circ C$
- Maximum Junction Temperature $175^\circ C$
- **Lead-Free Finish & RoHS Compliant (Notes 1 & 2)**
- **Halogen and Antimony Free. "Green" Device (Note 3)**

Applications

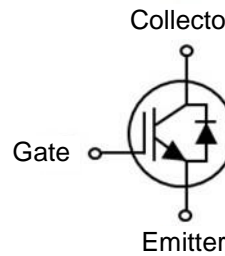
- UPS
- Welder
- Solar Inverter
- IH Cooker

Mechanical Data

- Case: TO-247 (Type MC)
- Case Material: Molded Plastic. "Green" Molding Compound.
- UL Flammability Classification Rating 94V-0
- Terminals: Finish – Matte Tin Plated Leads. Solderable per MIL-STD-202, Method 208 ^(E3)
- Weight: 5.6 grams (Approximate)



TO-247



Device Symbol

Ordering Information (Note 4)

Product	Marking	Quantity
DGTD65T50S1PT	DGTD65T50S1	450 per Box in Tubes (Note 5)

- Notes:
1. EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant. All applicable RoHS exemptions applied.
 2. See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
 4. For packaging details, go to our website at <https://www.diodes.com/design/support/packaging/diodes-packaging/>.
 5. 30 Devices per Tube.

Marking Information



$\text{D}|||$ = Manufacturer's Marking
 DGTD65T50S1 = Product Type Marking Code
 YY = Year (ex: 18 = 2018)
 LLLLL = Lot Code
 WW = Week (01 to 53)

Absolute Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit
Collector-Emitter Voltage	V _{CE}	650	V
DC Collector Current, limited by T _{vjmax}	I _C	T _C = 25°C	100
		T _C = 100°C	50
Pulsed Collector Current, t _p limited by T _{vjmax}	I _{Cpuls}	200	A
Turn Off Safe Operating Area V _{CE} ≤ 650V, T _{vj} = 175°C	-	200	A
Diode Forward Current limited by T _{vjmax}	I _F	T _C = 25°C	60
		T _C = 100°C	30
Diode Pulsed Current, t _p limited by T _{vjmax}	I _{Fpuls}	200	A
Gate-Emitter Voltage	V _{GE}	±20	V
Short Circuit Withstand Time V _{CC} ≤ 400V, V _{GE} = 15V, T _{vj} = 150°C Allowed Number of Short Circuits < 1000 Time Between Short Circuits ≥ 1.0s	tsc	5	μs

Thermal Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit
Power Dissipation Linear Derating Factor (Note 6)	P _D	T _C = 25°C	375
		T _C = 100°C	188
Thermal Resistance, Junction to Ambient (Note 6)	R _{θJA}	40	°C/W
Thermal Resistance, Junction to Case for IGBT (Note 6)	R _{θJC}	0.40	
Thermal Resistance, Junction to Case for Diode (Note 6)	R _{θJC}	1.20	
Operating Temperature	T _{vj}	-40 to +175	°C
Storage Temperature Range	T _{STG}	-55 to +150	

Note: 6. When mounted on a standard JEDEC 2-layer FR-4 board.

Electrical Characteristics (@ $T_{vj} = +25^{\circ}\text{C}$, unless otherwise specified.)

Parameter	Symbol	Min	Typ	Max	Unit	Condition	
STATIC CHARACTERISTICS							
Collector-Emitter Breakdown Voltage	BV_{CES}	650	–	–	V	$I_C = 2\text{mA}, V_{GE} = 0\text{V}$	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$T_{vj} = 25^{\circ}\text{C}$	–	1.85	2.40	V	$I_C = 50\text{A}, V_{GE} = 15\text{V}$
		$T_{vj} = 175^{\circ}\text{C}$	–	2.20	–		
Diode Forward Voltage	V_F	$T_{vj} = 25^{\circ}\text{C}$	–	1.65	2.05	V	$V_{GE} = 0\text{V}, I_F = 30\text{A}$
		$T_{vj} = 175^{\circ}\text{C}$	–	1.55	–		
Gate-Emitter Threshold Voltage	$V_{GE(th)}$	3.8	5.0	6.2	V	$V_{CE} = V_{GE}, I_C = 0.5\text{mA}$	
Zero Gate Voltage Collector Current	I_{CES}	–	–	40	μA	$V_{CE} = 650\text{V}, V_{GE} = 0\text{V}$	
Gate-Emitter Leakage Current	I_{GES}	–	–	± 100	nA	$V_{GE} = 20\text{V}, V_{CE} = 0\text{V}$	
DYNAMIC CHARACTERISTICS							
Total Gate Charge	Q_g	–	287	–	nC	$V_{CE} = 520\text{V}, I_C = 50\text{A}, V_{GE} = 15\text{V}$	
Gate-Emitter Charge	Q_{ge}	–	42	–			
Gate-Collector Charge	Q_{gc}	–	181	–			
Input Capacitance	C_{ies}	–	4,453	–	pF	$V_{CE} = 25\text{V}, V_{GE} = 0\text{V}, f = 1\text{MHz}$	
Reverse Transfer Capacitance	C_{res}	–	161	–			
Output Capacitance	C_{oes}	–	238	–			
Internal Emitter Inductance Measured 5mm (0.197") From Case	L_E	–	13	–	nH	–	
Short Circuit Collector Current Max. 1000 Short Circuits. Time Between Short Circuits $\geq 1.0\text{s}$	$I_{C(SC)}$	–	140	–	A	$V_{GE} = 15\text{V}, V_{CC} = 400\text{V}, t_{SC} \leq 5\mu\text{s}, T_{vj} = 150^{\circ}\text{C}$	
SWITCHING CHARACTERISTICS							
Turn-on Delay Time	$t_{d(on)}$	–	58	–	ns	$V_{GE} = 15\text{V}, V_{CC} = 400\text{V}, I_C = 50\text{A}, R_G = 7.9\Omega, \text{Inductive Load}, T_{vj} = 25^{\circ}\text{C}$	
Rise time	t_r	–	60	–			
Turn-off Delay Time	$t_{d(off)}$	–	328	–			
Fall Time	t_f	–	44	–	mJ		
Turn-on Switching Energy	E_{on}	–	0.77	–			
Turn-off Switching Energy	E_{off}	–	0.55	–			
Total Switching Energy	E_{ts}	–	1.32	–	ns	$I_F = 30\text{A}, di_F/dt = 1000\text{A}/\mu\text{s}, T_{vj} = 25^{\circ}\text{C}$	
Reverse Recovery Time	t_{rr}	–	80	–			
Reverse Recovery Current	I_{rr}	–	24	–	A		
Reverse Recovery Charge	Q_{rr}	–	0.95	–	μC	$V_{GE} = 15\text{V}, V_{CC} = 400\text{V}, I_C = 50\text{A}, R_G = 7.9\Omega, \text{Inductive Load}, T_{vj} = 175^{\circ}\text{C}$	
Turn-on Delay Time	$t_{d(on)}$	–	51	–	ns		
Rise time	t_r	–	66	–			
Turn-off Delay Time	$t_{d(off)}$	–	350	–		mJ	
Fall Time	t_f	–	49	–			
Turn-on Switching Energy	E_{on}	–	1.05	–			
Turn-off Switching Energy	E_{off}	–	0.55	–	ns	$I_F = 30\text{A}, di_F/dt = 1000\text{A}/\mu\text{s}, T_{vj} = 175^{\circ}\text{C}$	
Total Switching Energy	E_{ts}	–	1.6	–			
Reverse Recovery Time	t_{rr}	–	116	–			
Reverse Recovery Current	I_{rr}	–	34	–	A	$I_F = 30\text{A}, di_F/dt = 1000\text{A}/\mu\text{s}, T_{vj} = 175^{\circ}\text{C}$	
Reverse Recovery Charge	Q_{rr}	–	1.97	–	μC		

Typical Performance Characteristics (@ $T_A = +25^\circ\text{C}$, unless otherwise specified.)

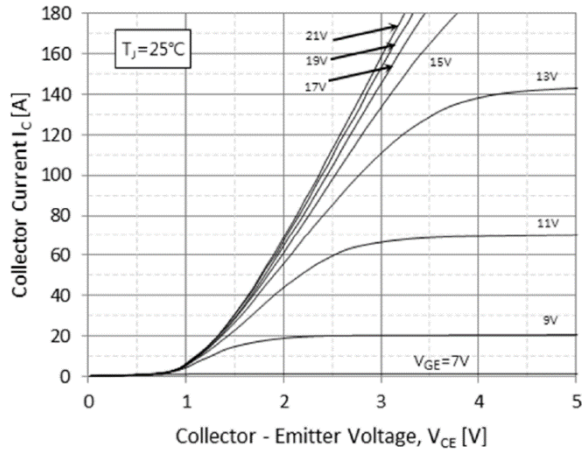


Fig.1 Typical Output Characteristics($T_J=25^\circ\text{C}$)

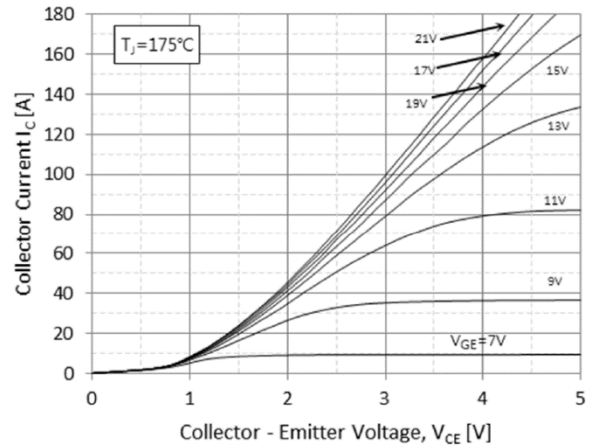


Fig.2 Typical Output Characteristics($T_J=175^\circ\text{C}$)

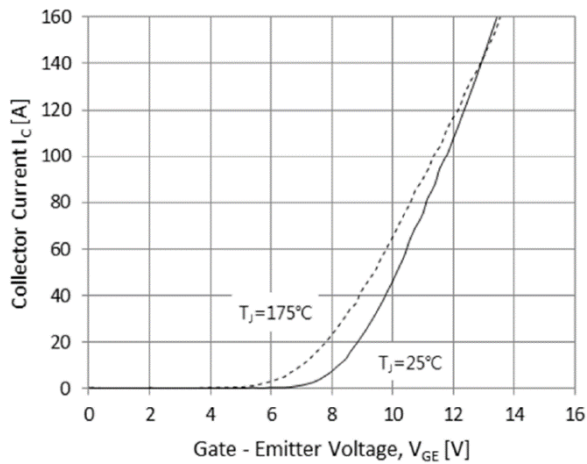


Fig.3 Typical Transfer Characteristics

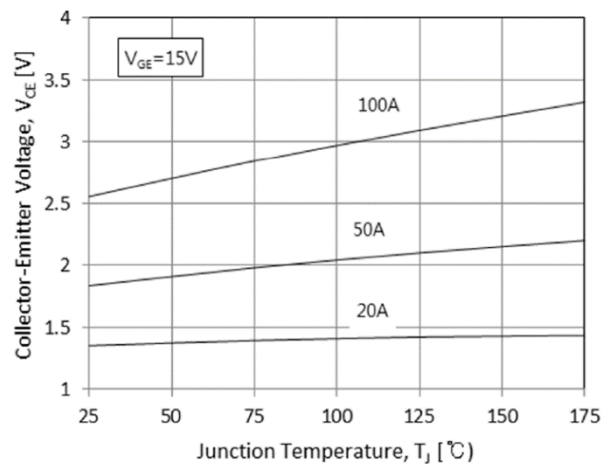


Fig.4 Typical Collector-Emitter Saturation Voltage - Junction Temperature

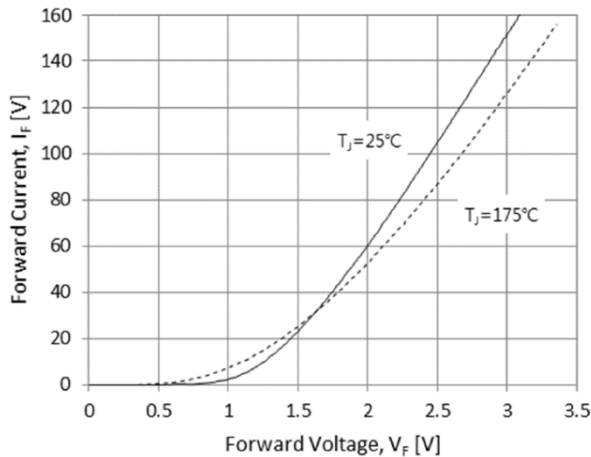


Fig.5 Diode Forward Characteristics

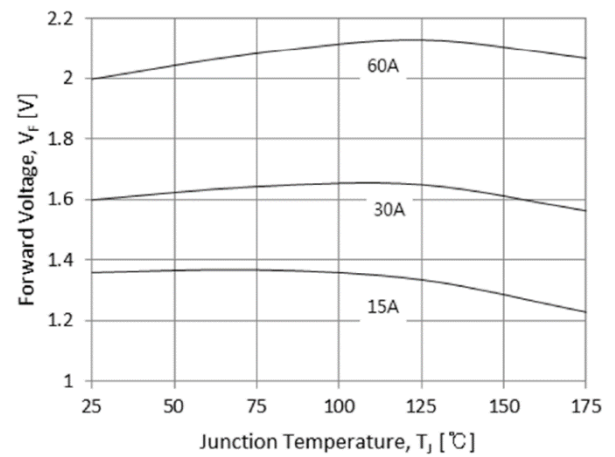


Fig.6 Diode Forward-Junction Temperature

Typical Performance Characteristics (continued)

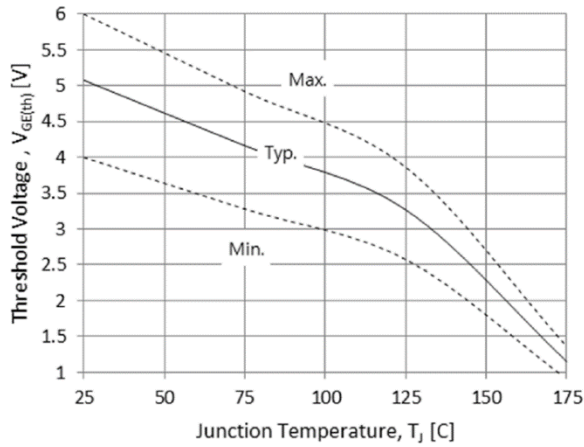


Fig.7 Threshold Voltage-Junction Temperature

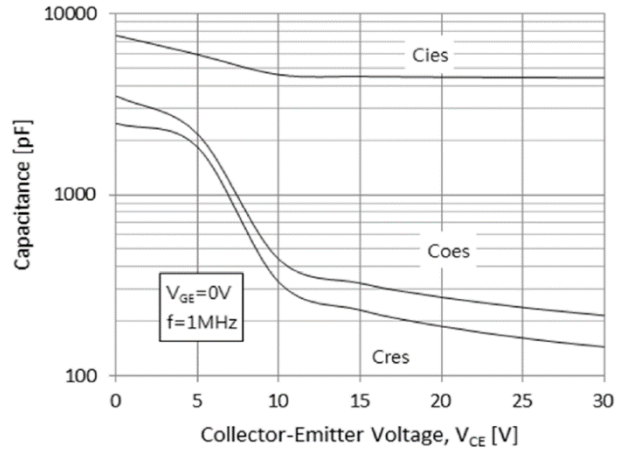


Fig.8 Typical Capacitance

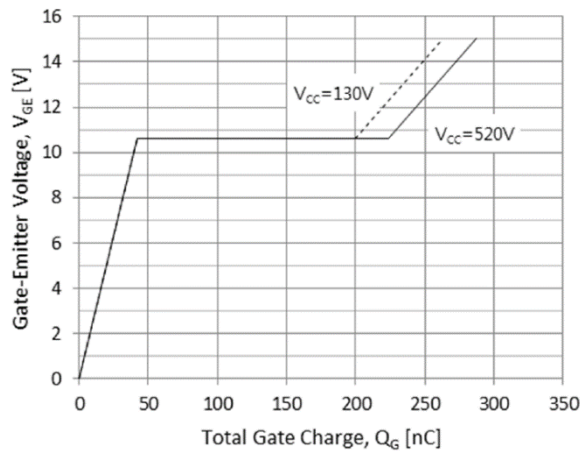


Fig.9 Typical Gate Charge

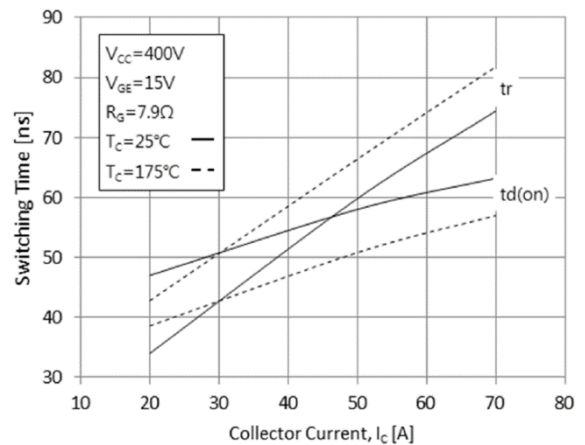


Fig.10 Typical Turn on-Collector Current

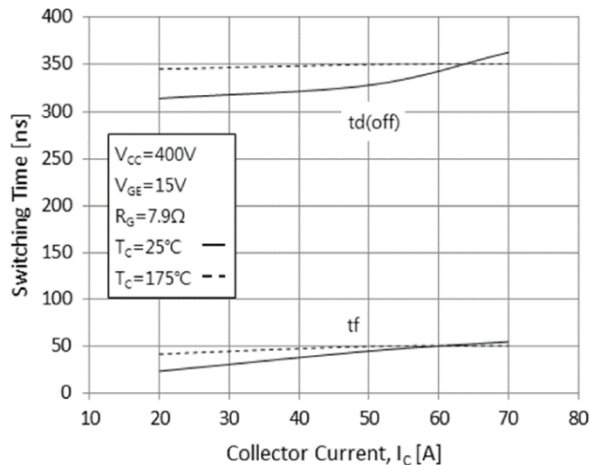


Fig.11 Typical Turn off-Collector Current

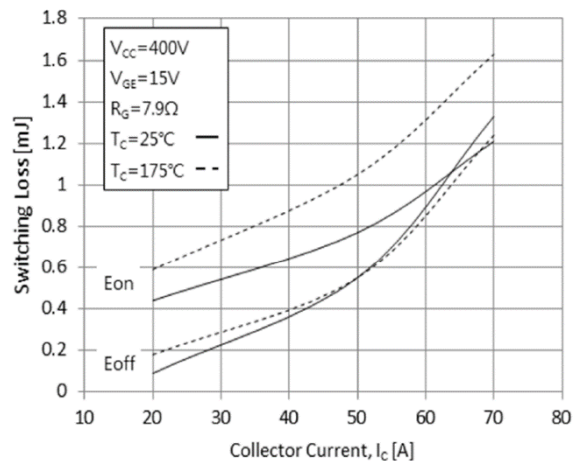


Fig.12 Switching Loss-Collector Current

Typical Performance Characteristics (cont.)

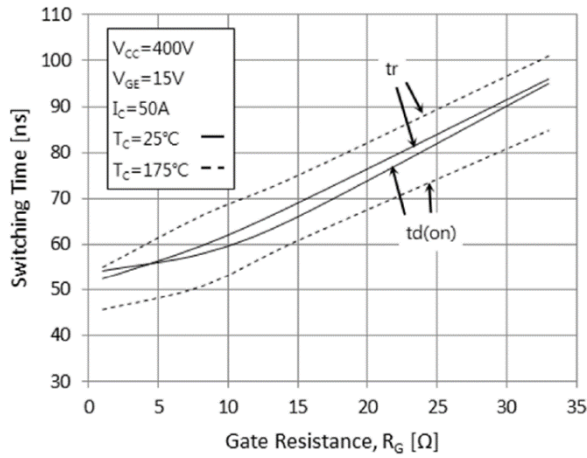


Fig.13 Turn on Characteristics-Gate Resistance

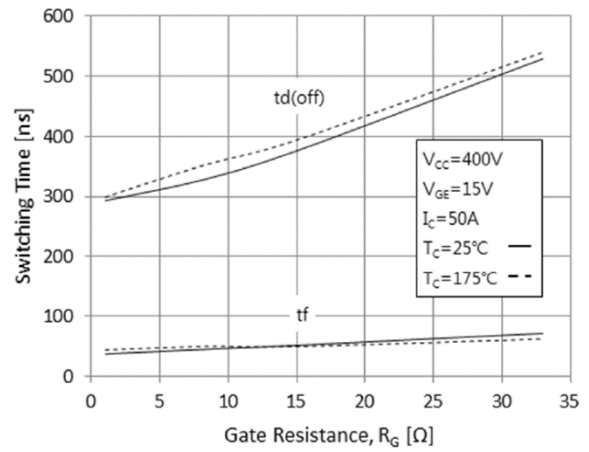


Fig.14 Turn off Characteristics-Gate Resistance

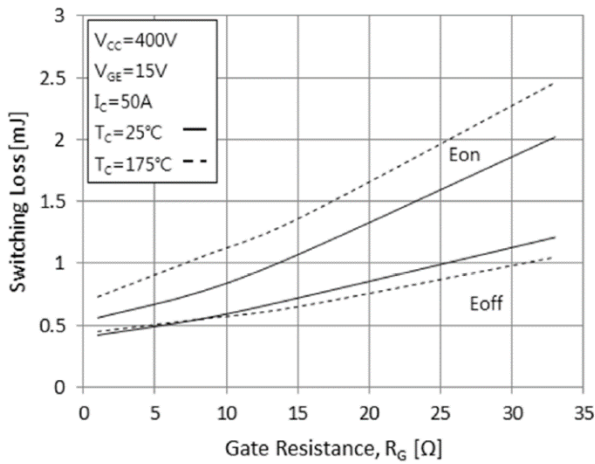


Fig.15 Switching Loss-Gate Resistance

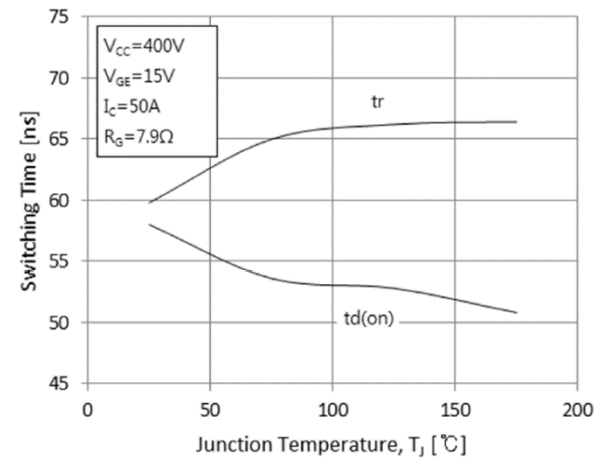


Fig.16 Turn on Characteristics-Junction Temperature

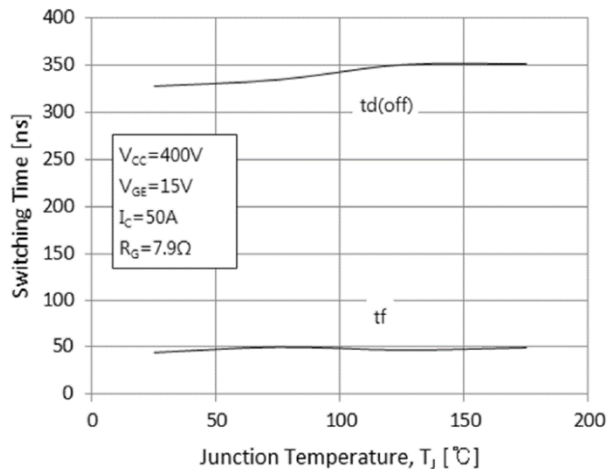


Fig.17 Turn off Characteristics-Junction Temperature

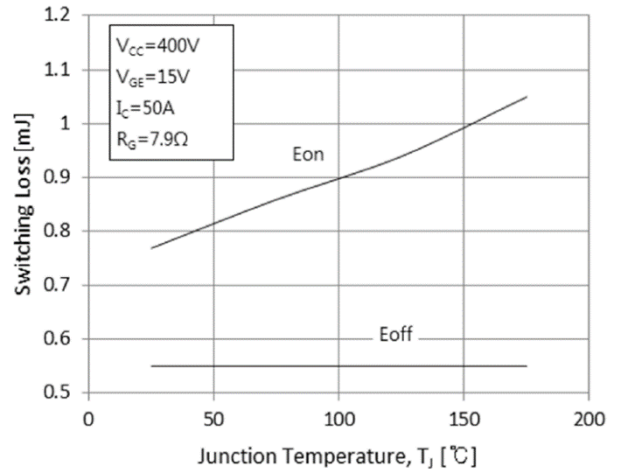


Fig.18 Switching Loss-Junction Temperature

Typical Performance Characteristics (cont.)

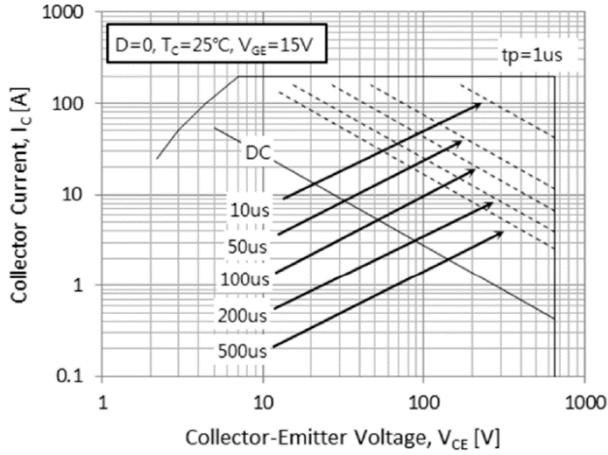


Fig.19 Forward Bias Safe Operating Area

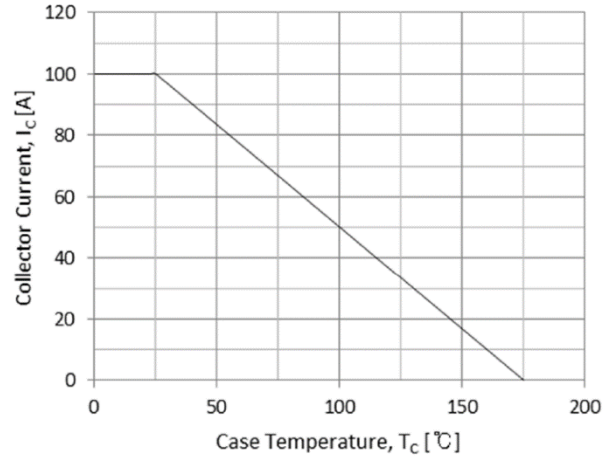


Fig.20 Case Temperature-Collector Current

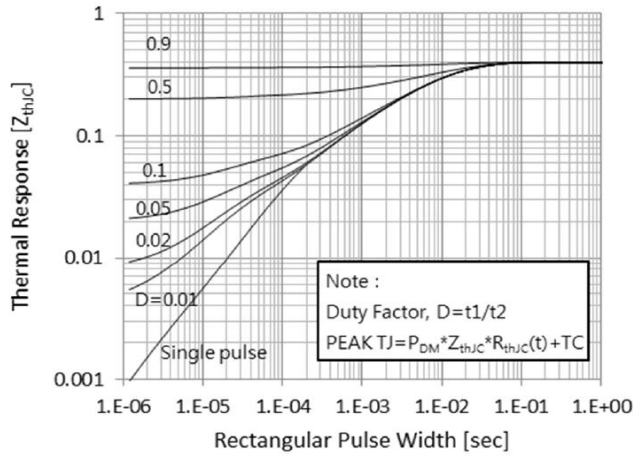


Fig.21 IGBT Transient Thermal Impedance

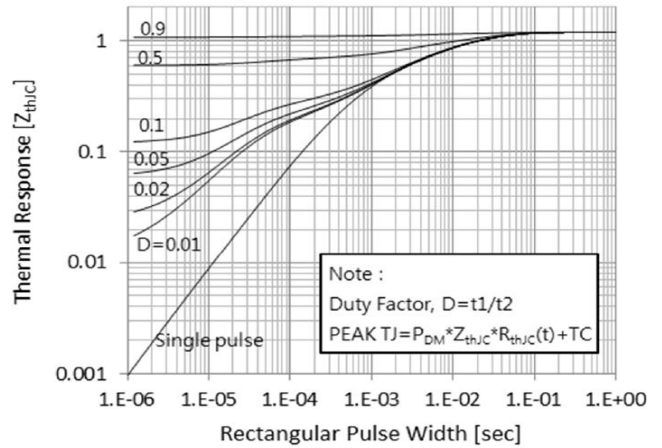
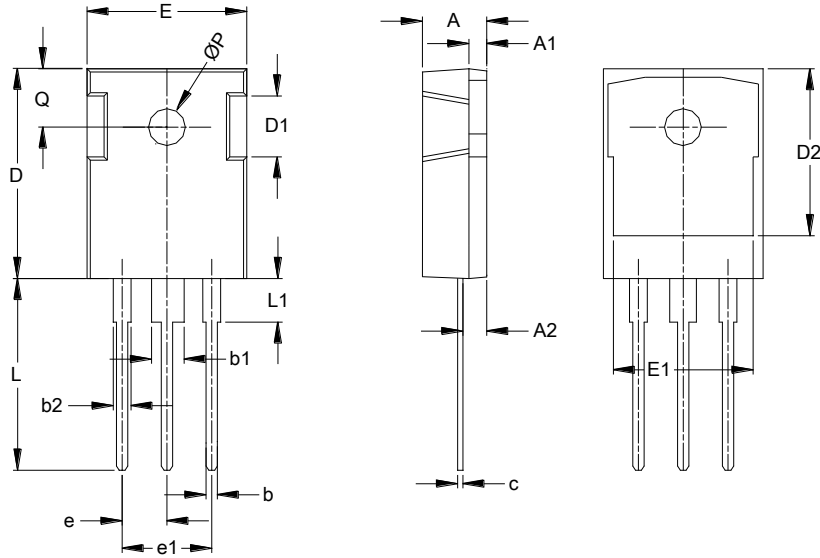


Fig.22 FRD Transient Thermal Impedance

Package Outline Dimensions

Please see <http://www.diodes.com/package-outlines.html> for the latest version.

TO-247 (Type MC)



TO-247 (Type MC)			
Dim	Min	Max	Typ
A	4.700	5.310	-
A1	1.500	2.490	-
A2	2.200	2.600	-
b	0.990	1.400	-
b1	2.590	3.430	-
b2	1.650	2.390	-
c	0.380	0.890	-
D	20.30	21.46	-
D1	4.320	5.490	-
D2	13.08	-	-
E	15.45	16.26	-
E1	13.06	14.02	-
e	5.450		
e1	10.90		
L	19.81	20.57	-
L1	-	4.500	-
Q	5.380	6.200	-
øP	3.500	3.700	-
All Dimensions in mm			

Note : For high-voltage applications, the appropriate industry sector guidelines should be considered with regards to creepage and clearance distances between device Terminals and PCB tracking.

IMPORTANT NOTICE

DIODES INCORPORATED MAKES NO WARRANTY OF ANY KIND, EXPRESS OR IMPLIED, WITH REGARDS TO THIS DOCUMENT, INCLUDING, BUT NOT LIMITED TO, THE IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A PARTICULAR PURPOSE (AND THEIR EQUIVALENTS UNDER THE LAWS OF ANY JURISDICTION).

Diodes Incorporated and its subsidiaries reserve the right to make modifications, enhancements, improvements, corrections or other changes without further notice to this document and any product described herein. Diodes Incorporated does not assume any liability arising out of the application or use of this document or any product described herein; neither does Diodes Incorporated convey any license under its patent or trademark rights, nor the rights of others. Any Customer or user of this document or products described herein in such applications shall assume all risks of such use and will agree to hold Diodes Incorporated and all the companies whose products are represented on Diodes Incorporated website, harmless against all damages.

Diodes Incorporated does not warrant or accept any liability whatsoever in respect of any products purchased through unauthorized sales channel. Should Customers purchase or use Diodes Incorporated products for any unintended or unauthorized application, Customers shall indemnify and hold Diodes Incorporated and its representatives harmless against all claims, damages, expenses, and attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized application.

Products described herein may be covered by one or more United States, international or foreign patents pending. Product names and markings noted herein may also be covered by one or more United States, international or foreign trademarks.

This document is written in English but may be translated into multiple languages for reference. Only the English version of this document is the final and determinative format released by Diodes Incorporated.

LIFE SUPPORT

Diodes Incorporated products are specifically not authorized for use as critical components in life support devices or systems without the express written approval of the Chief Executive Officer of Diodes Incorporated. As used herein:

A. Life support devices or systems are devices or systems which:

1. are intended to implant into the body, or
2. support or sustain life and whose failure to perform when properly used in accordance with instructions for use provided in the labeling can be reasonably expected to result in significant injury to the user.

B. A critical component is any component in a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or to affect its safety or effectiveness.

Customers represent that they have all necessary expertise in the safety and regulatory ramifications of their life support devices or systems, and acknowledge and agree that they are solely responsible for all legal, regulatory and safety-related requirements concerning their products and any use of Diodes Incorporated products in such safety-critical, life support devices or systems, notwithstanding any devices- or systems-related information or support that may be provided by Diodes Incorporated. Further, Customers must fully indemnify Diodes Incorporated and its representatives against any damages arising out of the use of Diodes Incorporated products in such safety-critical, life support devices or systems.

Copyright © 2018, Diodes Incorporated

www.diodes.com

Данный компонент на территории Российской Федерации

Вы можете приобрести в компании MosChip.

Для оперативного оформления запроса Вам необходимо перейти по данной ссылке:

<http://moschip.ru/get-element>

Вы можете разместить у нас заказ для любого Вашего проекта, будь то серийное производство или разработка единичного прибора.

В нашем ассортименте представлены ведущие мировые производители активных и пассивных электронных компонентов.

Нашей специализацией является поставка электронной компонентной базы двойного назначения, продукции таких производителей как XILINX, Intel (ex.ALTERA), Vicor, Microchip, Texas Instruments, Analog Devices, Mini-Circuits, Amphenol, Glenair.

Сотрудничество с глобальными дистрибьюторами электронных компонентов, предоставляет возможность заказывать и получать с международных складов практически любой перечень компонентов в оптимальные для Вас сроки.

На всех этапах разработки и производства наши партнеры могут получить квалифицированную поддержку опытных инженеров.

Система менеджмента качества компании отвечает требованиям в соответствии с ГОСТ Р ИСО 9001, ГОСТ РВ 0015-002 и ЭС РД 009

Офис по работе с юридическими лицами:

105318, г.Москва, ул.Щербаковская д.3, офис 1107, 1118, ДЦ «Щербаковский»

Телефон: +7 495 668-12-70 (многоканальный)

Факс: +7 495 668-12-70 (доб.304)

E-mail: info@moschip.ru

Skype отдела продаж:

moschip.ru

moschip.ru_4

moschip.ru_6

moschip.ru_9